

# N-Channel Enhancement Mode Power MOSFET

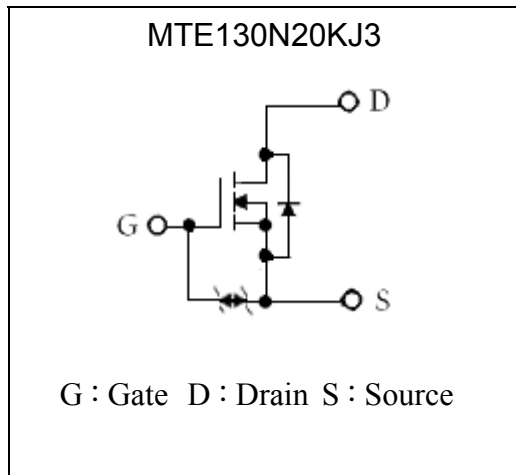
## MTE130N20KJ3

BV <sub>DSS</sub>	200V
I <sub>D</sub>	18A
R <sub>DS(on)(TYP)</sub> @ V <sub>GS</sub> =10V, I <sub>D</sub> =9A	142mΩ

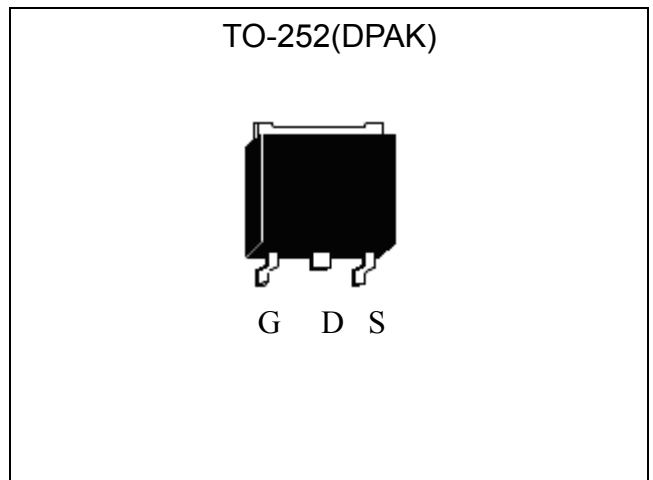
### Features

- Low Gate Charge
- Simple Drive Requirement
- ESD Diode Protected Gate
- Fast Switching Characteristic
- Pb-free lead plating and halogen-free package

### Symbol

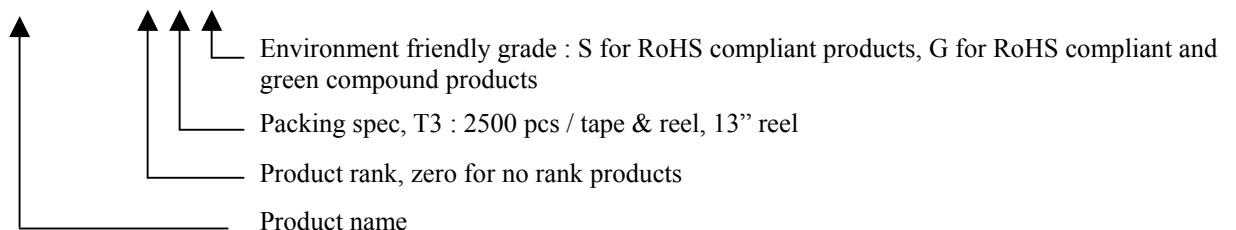


### Outline



### Ordering Information

Device	Package	Shipping
MTE130N20KJ3-0-T3-G	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel



**Absolute Maximum Ratings** ( $T_C=25^\circ\text{C}$ , unless otherwise noted)

Parameter		Symbol	Limits	Unit	
Drain-Source Voltage		$V_{DS}$	200	V	
Gate-Source Voltage		$V_{GS}$	$\pm 20$		
Continuous Drain Current @ $T_C=25^\circ\text{C}$	(Note 1)	$I_D$	18	A	
Continuous Drain Current @ $T_C=100^\circ\text{C}$	(Note 1)		13		
Pulsed Drain Current	(Note 3)	$I_{DM}$	30		
Continuous Drain Current @ $T_A=25^\circ\text{C}$	(Note 4)	$I_{DSM}$	1.9		
Continuous Drain Current @ $T_A=70^\circ\text{C}$	(Note 4)		1.5		
Avalanche Current	(Note 3)	$I_{AS}$	10		
Avalanche Energy @ $L=100\mu\text{H}$ , $I_D=9\text{A}$ , $V_{DD}=50\text{V}$		(Note 3)	$E_{AS}$	4	mJ
Power Dissipation	$T_C=25^\circ\text{C}$	(Note 1)	$P_D$	125	W
	$T_C=100^\circ\text{C}$	(Note 1)		62.5	
Power Dissipation	$T_A=25^\circ\text{C}$	(Note 2)	$P_{DSM}$	2	W
	$T_A=70^\circ\text{C}$	(Note 2)		1.3	
Operating Junction and Storage Temperature		$T_j, T_{stg}$	-55~+175	$^\circ\text{C}$	

**Thermal Data**

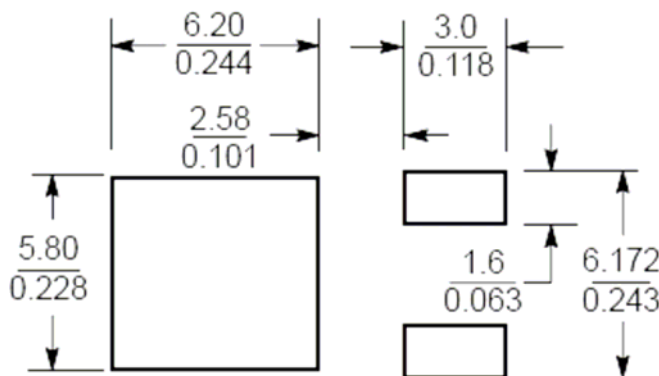
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	1.2	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max, $t \leq 10\text{s}$	$R_{th,j-a}$	62.5	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max		(Note 4)	90

- Note : 1. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
3. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=175^\circ\text{C}$ . Ratings are based on low frequency and low duty cycles to keep initial  $T_j=25^\circ\text{C}$ .
4. When mounted on the minimum pad size recommended (PCB mount),  $t \leq 10\text{s}$ .

**Characteristics (Tc=25°C, unless otherwise specified)**

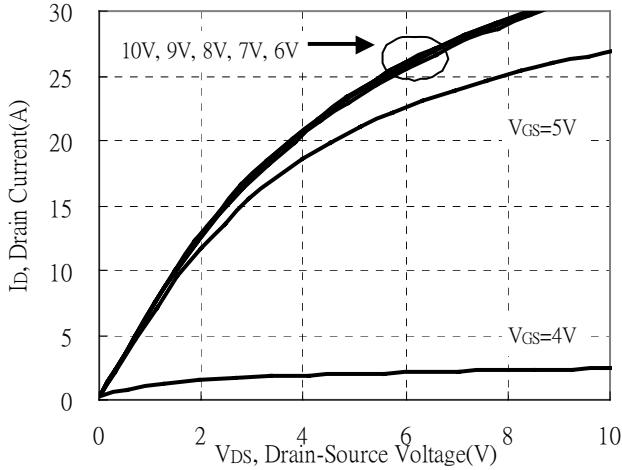
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	200	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	-	0.2	-	V/°C	Reference to 25°C, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	2.0	3.0	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	14	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =9A
I <sub>GSS</sub>	-	-	±10	μA	V <sub>GS</sub> =±20V
I <sub>DSS</sub>	-	-	1		V <sub>DS</sub> =180V, V <sub>GS</sub> =0V
	-	-	10		V <sub>DS</sub> =180V, V <sub>GS</sub> =0V, T <sub>j</sub> =125°C
*R <sub>DS(ON)</sub>	-	142	185	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =9A
<b>Dynamic</b>					
*Q <sub>g</sub>	-	22	-	nC	V <sub>DS</sub> =160V, I <sub>D</sub> =18A, V <sub>GS</sub> =10V
*Q <sub>gs</sub>	-	5.5	-		
*Q <sub>gd</sub>	-	9.4	-		
*t <sub>d(ON)</sub>	-	21	-	ns	V <sub>DS</sub> =100V, I <sub>D</sub> =18A, V <sub>GS</sub> =10V, R <sub>G</sub> =6Ω
*t <sub>r</sub>	-	32	-		
*t <sub>d(OFF)</sub>	-	40	-		
*t <sub>f</sub>	-	30	-		
C <sub>iss</sub>	-	968	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz
C <sub>oss</sub>	-	83	-		
C <sub>rss</sub>	-	37	-		
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	18	A	
*I <sub>SM</sub>	-	-	30		
*V <sub>SD</sub>	-	0.86	1.2	V	I <sub>S</sub> =18A, V <sub>GS</sub> =0V
*t <sub>rr</sub>	-	90	-	ns	I <sub>F</sub> =18A, V <sub>GS</sub> =0, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	260	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

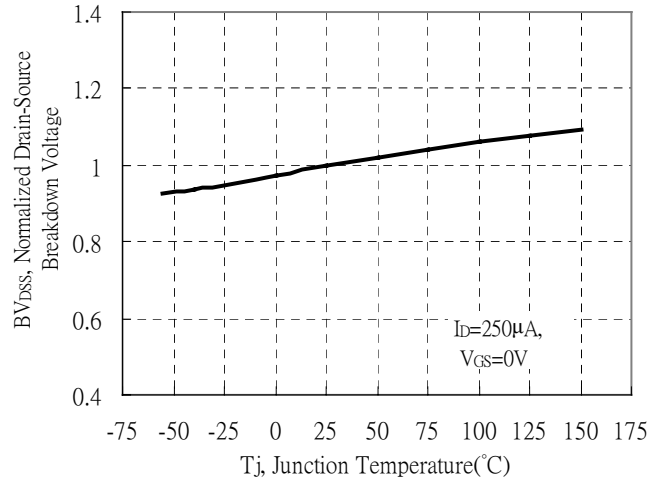
**Recommended soldering footprint**

 Unit (  $\frac{\text{mm}}{\text{inch}}$  )

## Typical Characteristics

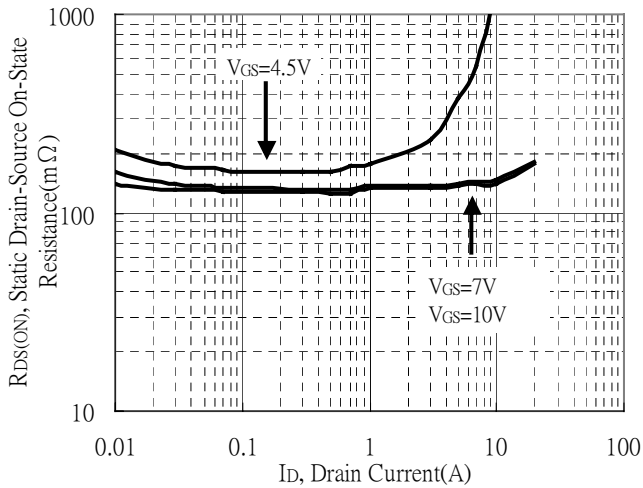
Typical Output Characteristics



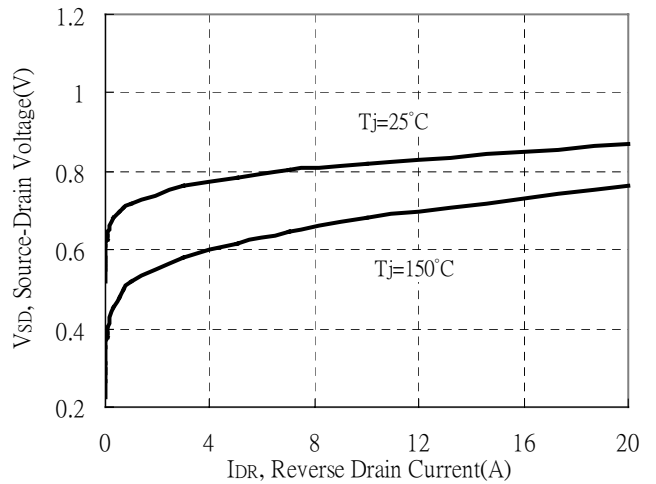
Brekdown Voltage vs Ambient Temperature



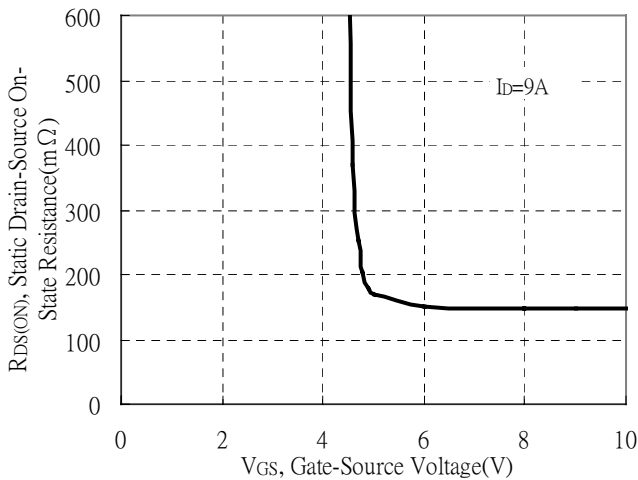
Static Drain-Source On-State resistance vs Drain Current



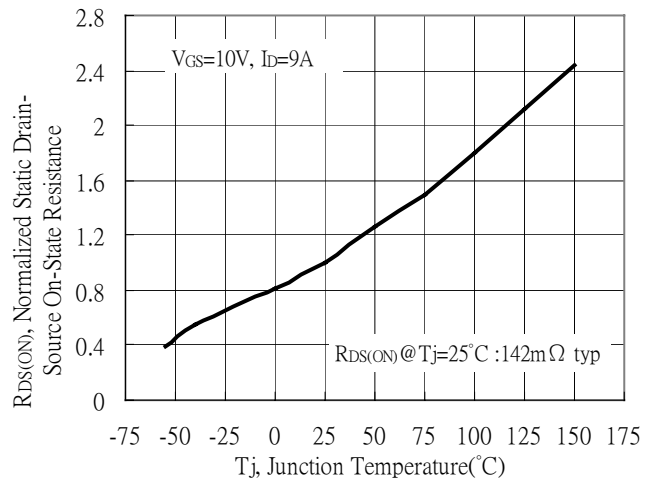
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

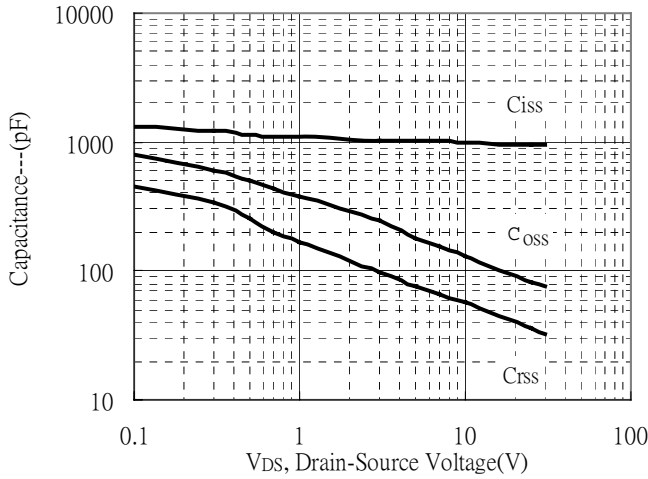


Drain-Source On-State Resistance vs Junction Temperature

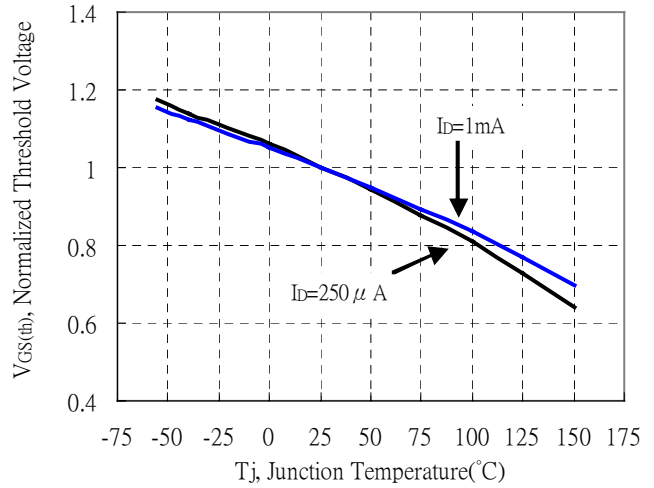


**Typical Characteristics(Cont.)**

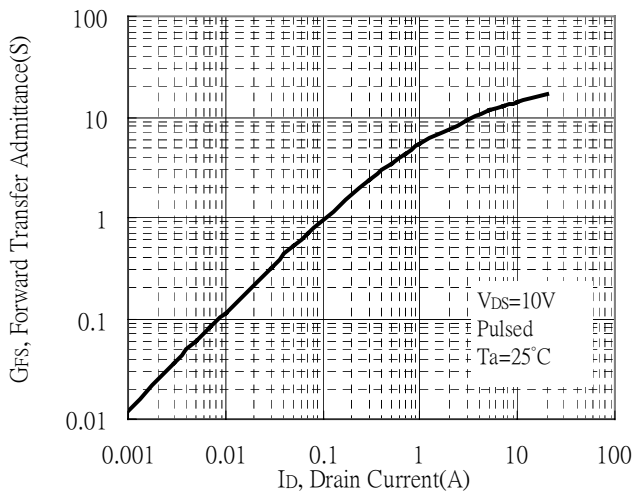
Capacitance vs Drain-to-Source Voltage



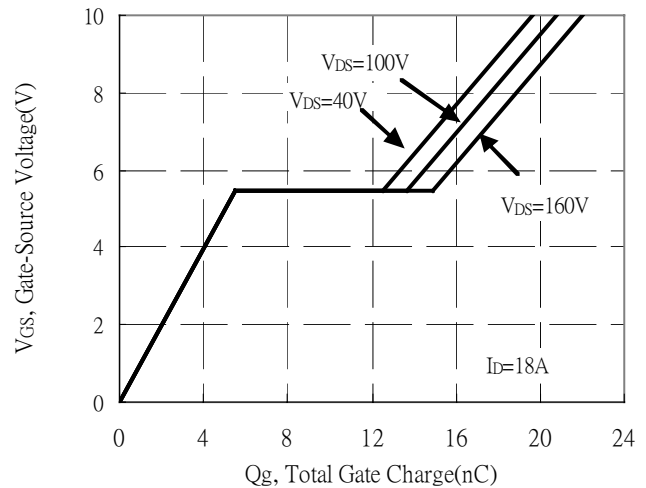
Normalized Threshold Voltage vs Junction Temperature



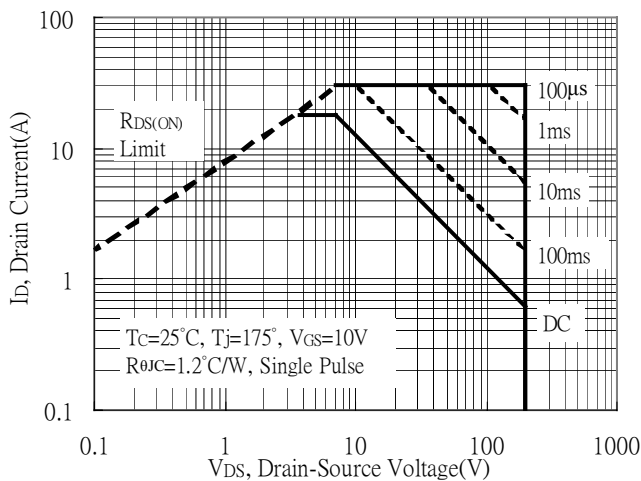
Forward Transfer Admittance vs Drain Current



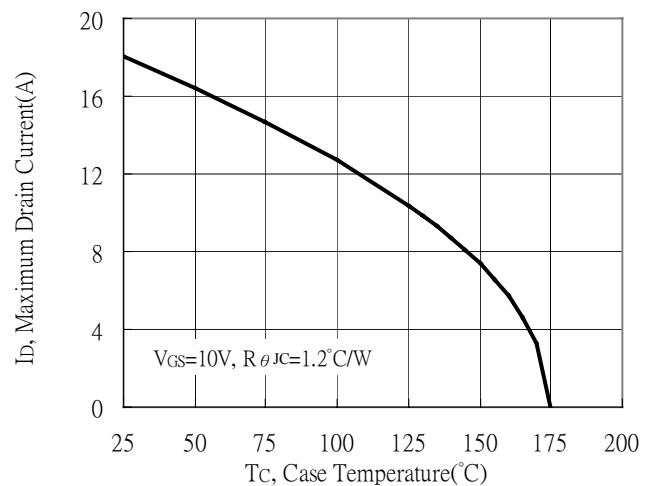
Gate Charge Characteristics



Maximum Safe Operating Area



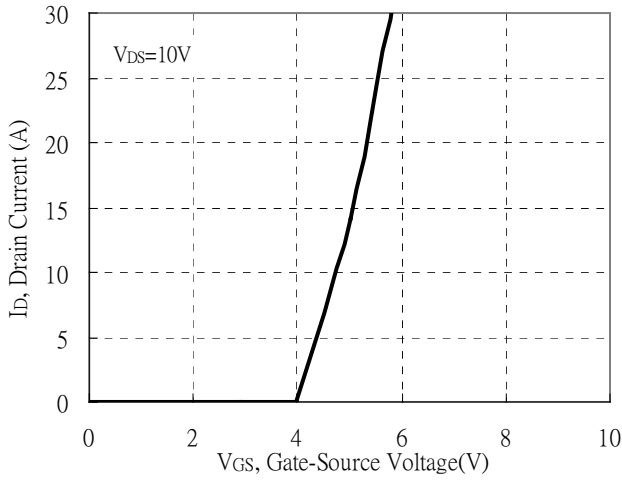
Maximum Drain Current vs Case Temperature



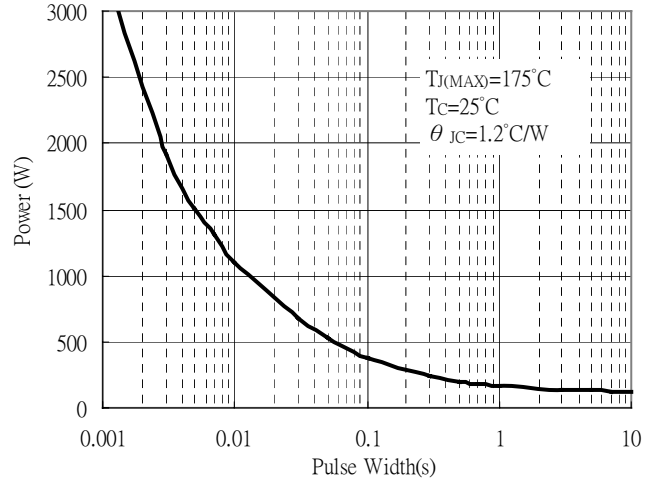


**Typical Characteristics(Cont.)**

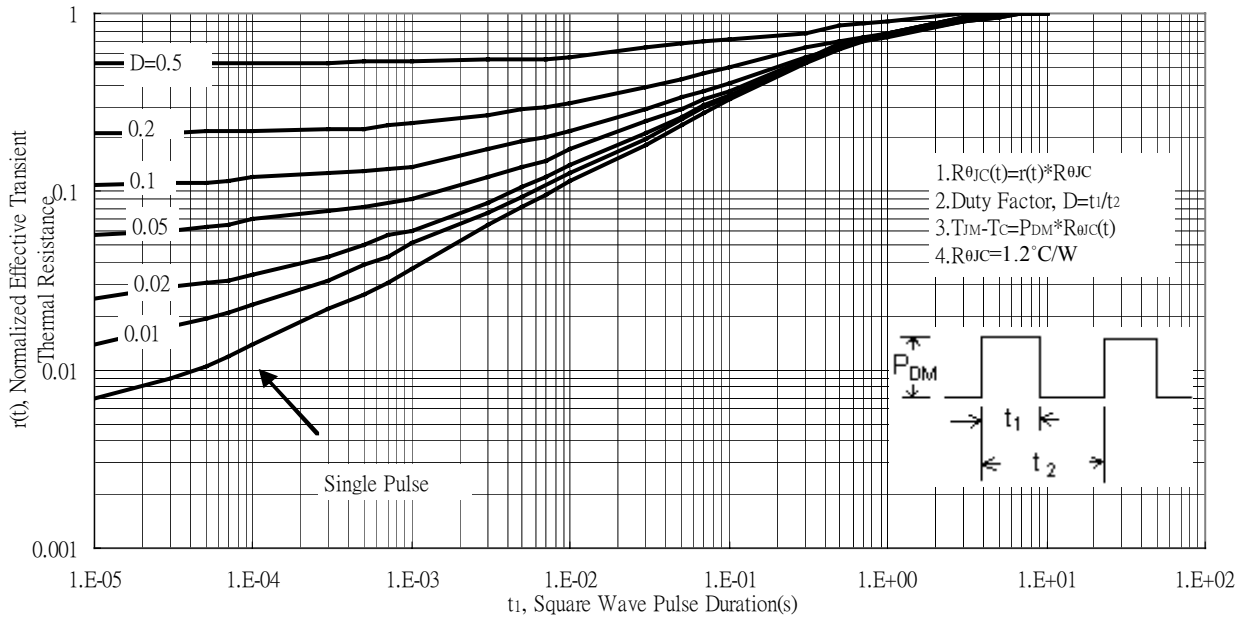
Typical Transfer Characteristics



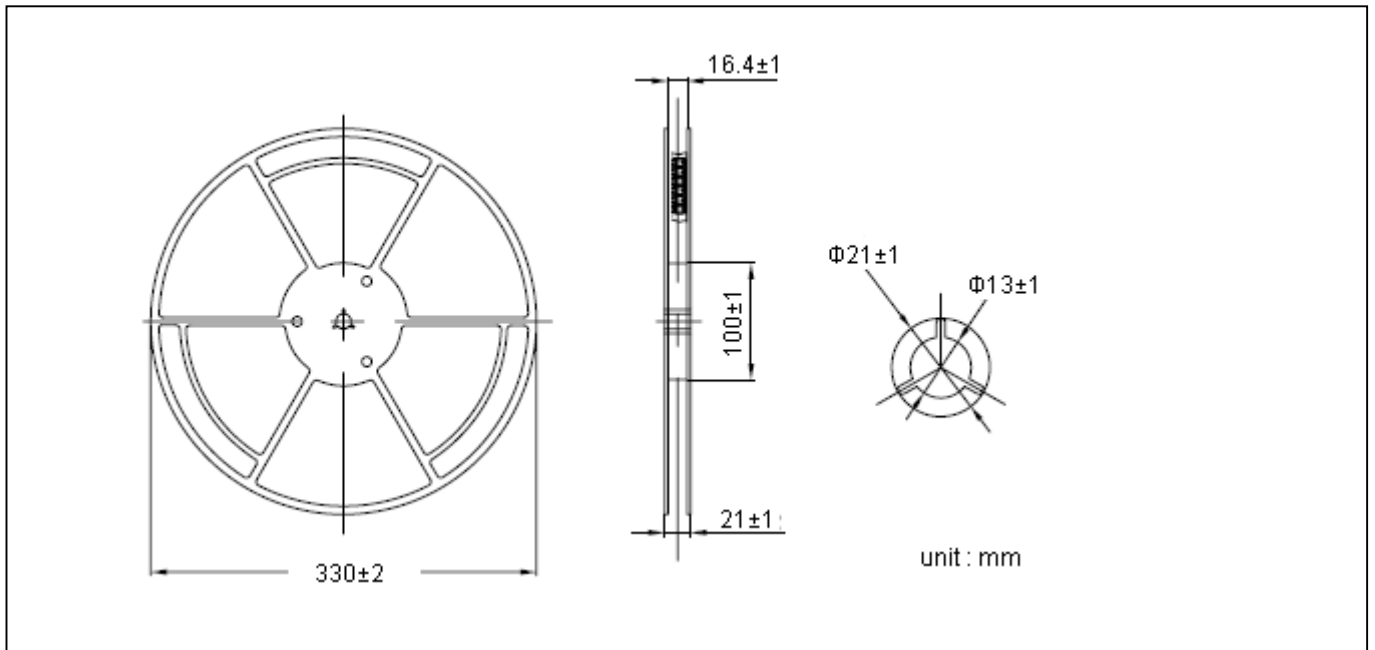
Single Pulse Maximum Power Dissipation



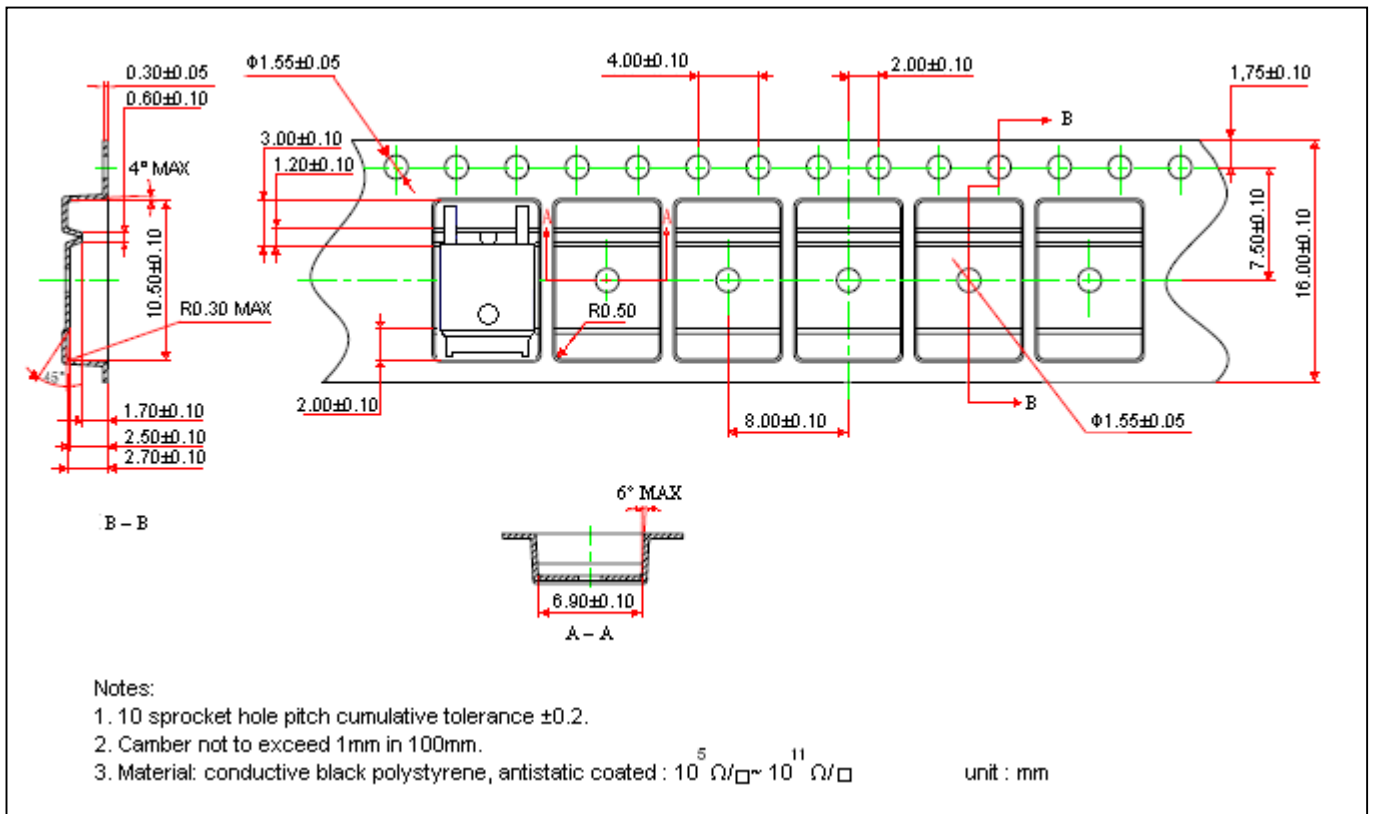
Transient Thermal Response Curves



## Reel Dimension



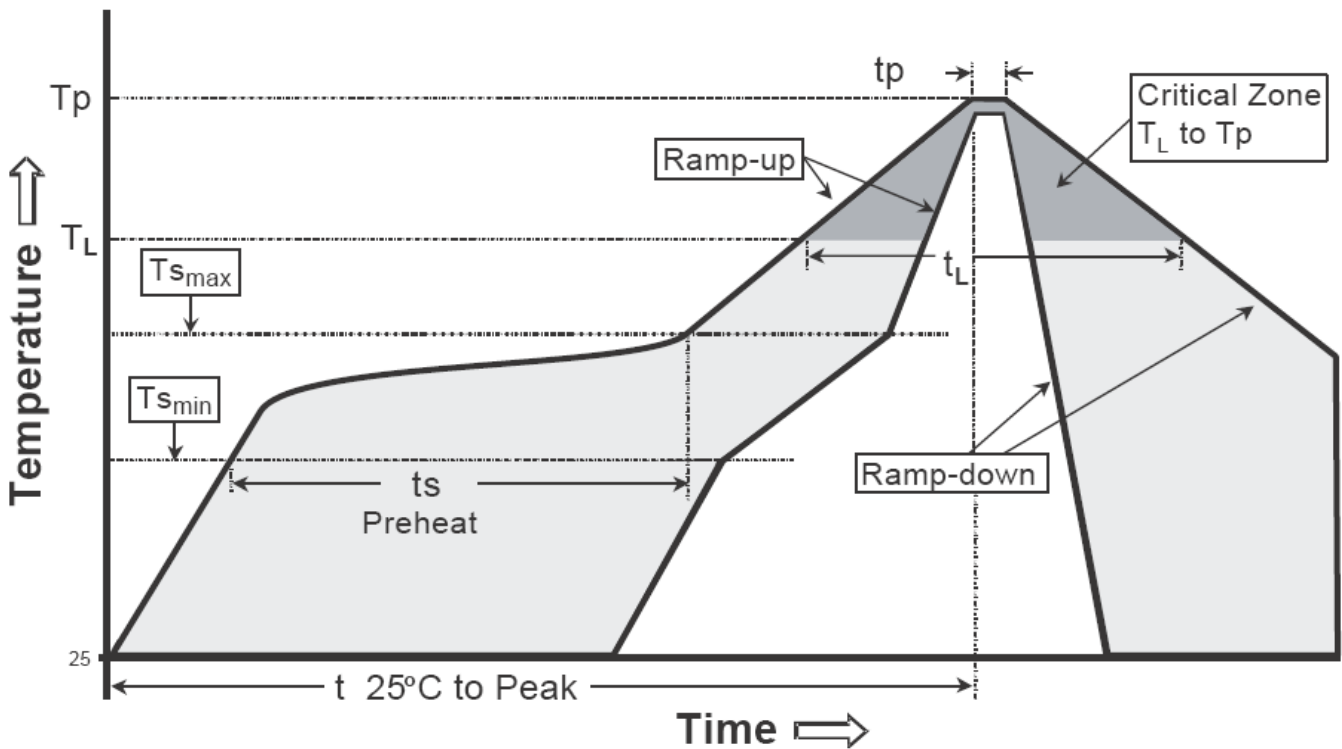
## Carrier Tape Dimension



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**

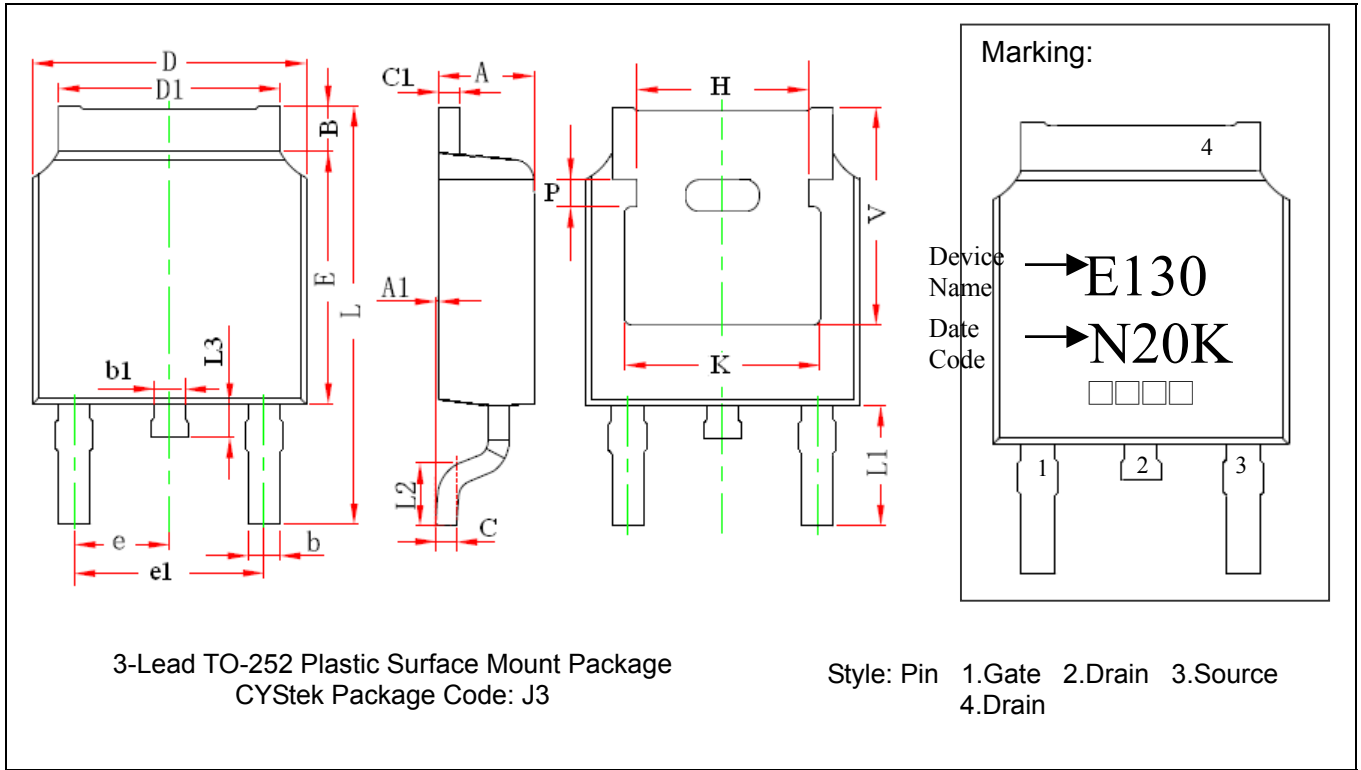


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(t <sub>p</sub> )	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.



**TO-252 Dimension**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF

- Notes:**
- Controlling dimension: millimeters.
  - Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
  - If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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